

Search Notes

Application/Control No.

10/766,373

Examiner

Leith A. Al-Nazer

Applicant(s)/Patent under
Reexamination

ZHOU ET AL.

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
372	109	4/20/2005	LA
356	300	4/20/2005	LA
356	326	4/20/2005	LA
356	451	4/20/2005	LA

INTERFERENCE SEARCHED

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372	109	4/20/2005	LA
356	300	4/20/2005	LA
356	326	4/20/2005	LA
356/451		4/20/2005	LA

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search (see Examiner Search Notes)	4/20/2005	LA